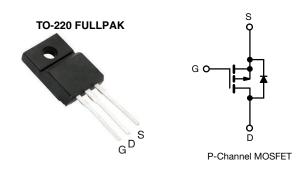
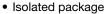


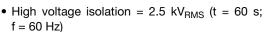
Power MOSFET



PRODUCT SUMMARY					
V _{DS} (V)	-200				
R _{DS(on)} (Ω)	V _{GS} = -10 V 1.5				
Q _g (Max.) (nC)	15				
Q _{gs} (nC)	3.2				
Q _{gd} (nC)	8.4				
Configuration	Single				

FEATURES







• Sink to lead creepage distance = 4.8 mm

- P-channel
- Dynamic dV/dt rating
- Low thermal resistance
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRFI9620GPbF

ABSOLUTE MAXIMUM RATINGS T _C =	= 25 °C, unle	ess otherwis	e noted		
PARAMETER			SYMBOL	LIMIT	UNIT
Drain-source voltage			V_{DS}	-200	V
Gate-source voltage			V_{GS}	± 20	7 v
Continuous drain current	V at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	1	-3.0	
Continuous drain current	V _{GS} at -10 V	T _C = 100 °C	I _D	-1.9	Α
Pulsed drain current ^a			I _{DM}	-12	
Linear derating factor				0.24	W/°C
Single pulse avalanche energy b			E _{AS}	80	mJ
Repetitive avalanche current a			I _{AR}	-3.0	Α
Repetitive avalanche energy a			E _{AR}	3.0	mJ
Maximum power dissipation $T_C = 25 ^{\circ}C$			P _D	30	W
Peak diode recovery dV/dt ^c			dV/dt	-5.0	V/ns
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +175	°C	
Soldering recommendations (peak temperature) d For 10 s		-	300	7	
Mounting torque M3 screw				0.6	Nm

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. $V_{DD} = -50 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 13 \,^{\circ}\text{mH}$, $R_G = 25 \,^{\circ}\Omega$, $I_{AS} = -3.0 \,^{\circ}\Lambda$ (see fig. 12)
- c. $I_{SD} \le -3.9$ A, $dI/dt \le 95$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C
- d. 1.6 mm from case



Vishay Siliconix

THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum junction-to-ambient	R _{thJA}	-	65	°C/W
Maximum junction-to-case (drain)	R _{thJC}	-	4.1	C/VV

PARAMETER	SYMBOL	TES	TEST CONDITIONS		TYP.	MAX.	UNIT
Static							
Drain-ssource breakdown voltage	V _{DS}	V _{GS} =	= 0 V, I _D = -250 μA	-200	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = -1 mA	-	-0.22	-	V/°C
Gate-source threshold voltage	V _{GS(th)}	V _{DS} =	V _{GS} , I _D = -250 μA	-2.0	-	-4.0	V
Gate-source leakage	I _{GSS}		V _{GS} = ± 20 V	-	-	± 100	nA
7ll		V _{DS} =	-200 V, V _{GS} = 0 V	-	-	-100	
Zero gate voltage drain current	I _{DSS}	V _{DS} = -160 \	V, V _{GS} = 0 V, T _J = 125 °C	-	-	-500	μA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = -10 V	I _D = -1.8 A ^b	-	-	1.5	Ω
Forward transconductance	9 _{fs}	V _{DS} =	-50 V, I _D = -1.8 A ^b	1.3	-	-	S
Dynamic		•					
Input capacitance	C _{iss}		V _{GS} = 0 V,	-	340	-	
Output capacitance	Coss		$V_{DS} = -15 V$,	-	110	-	рF
Reverse transfer capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	33	-	
Drain to sink capacitance	С		f = 1 MHz	-	12	-	
Total gate charge	Qg			-	-	15	
Gate-source charge	Q _{gs}	V _{GS} = -10 V	$I_D = -2.1 \text{ A}, V_{DS} = -160 \text{ V},$ see fig. 6 and 13 ^b	-	-	3.2	nC
Gate-drain charge	Q _{gd}		See lig. 0 and 10	-	-	8.4	
Turn-on delay time	t _{d(on)}			-	8.8	-	
Rise time	t _r		$-100 \text{ V}, I_D = -3.9 \text{ A},$	-	27	-	
Turn-off delay time	t _{d(off)}	$ R_{G} =$	$= 18 \Omega_{\rm p} R_{\rm D} = 24 \Omega_{\rm p}$ see fig. $10^{\rm b}$	-	7.3	-	ns
Fall time	t _f			-	19	-	1
Internal drain inductance	L _D	Between lead, 6 mm (0.25") from		-	4.5	-	
Internal source inductance	L _S	package and center of die contact		-	7.5	-	- nH
Drain-Source Body Diode Characteristic	cs	-			l	l.	
Continuous source-drain diode current	I _S	MOSFET sym		-	-	-3.0	A
Pulsed diode forward current ^a	I _{SM}	integral reverse p - n junction diode		ı	-	-12	
Body diode voltage	V _{SD}	$T_{J} = 25 ^{\circ}\text{C}, I_{S} = -3.0 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	-6.3	V
Body diode reverse recovery time	t _{rr}	T _ 05 %C .	- 20 A dI/dt 100 A/:h	-	150	300	ns
Body diode reverse recovery charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = -3.9 \text{A}, dI/dt = 100 \text{A/}\mu\text{s}^b$		-	0.97	2.0	μC
Forward turn-on time	t _{on}	Intrinsic tu	ırn-on time is negligible (turn	on is dor	ninated b	y L _S and	L _D)

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

b. Pulse width $\leq 300~\mu s;~duty~cycle \leq 2~\%$



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

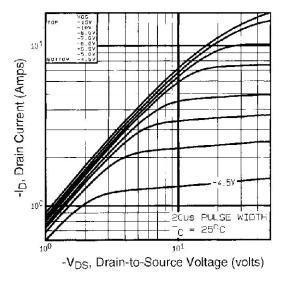


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

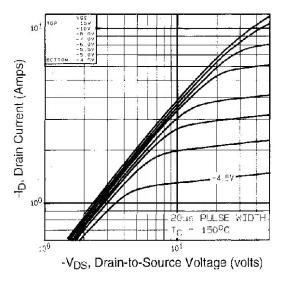


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

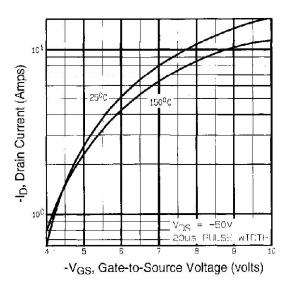


Fig. 3 - Typical Transfer Characteristics

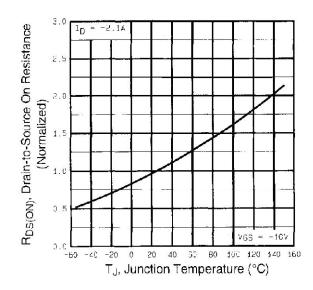


Fig. 4 - Normalized On-Resistance vs. Temperature



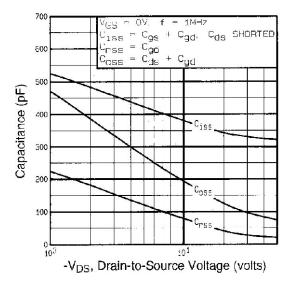


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

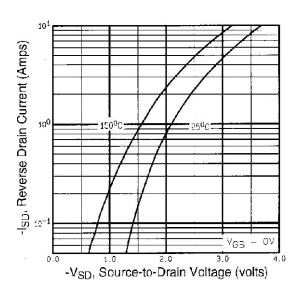


Fig. 7 - Typical Source-Drain Diode Forward Voltage

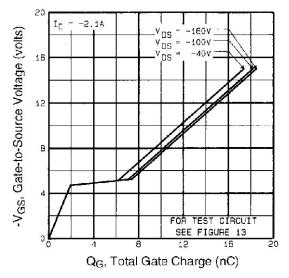


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

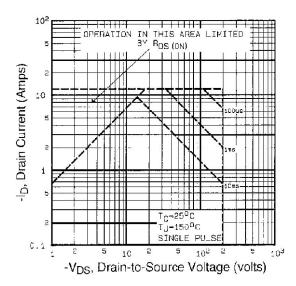


Fig. 8 - Maximum Safe Operating Area



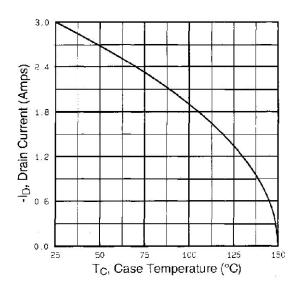


Fig. 9 - Maximum Drain Current vs. Case Temperature

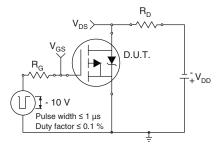


Fig. 10a - Switching Time Test Circuit

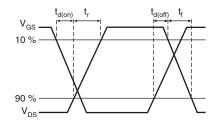


Fig. 10b - Switching Time Waveforms

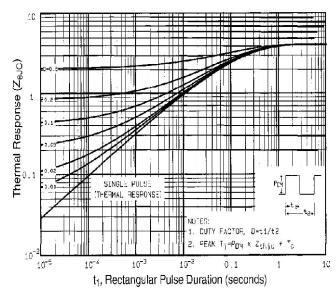


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



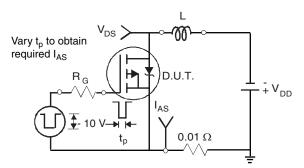


Fig. 12a - Unclamped Inductive Test Circuit

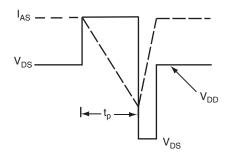


Fig. 12b - Unclamped Inductive Waveforms

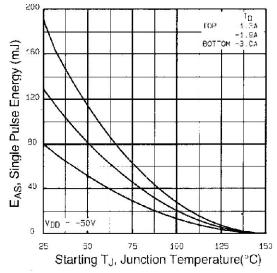


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

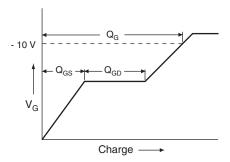


Fig. 13a - Basic Gate Charge Waveform

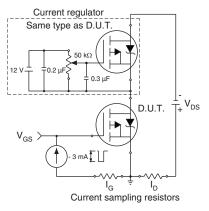
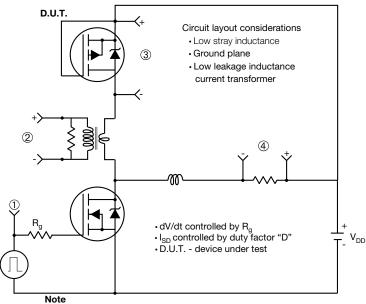


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver

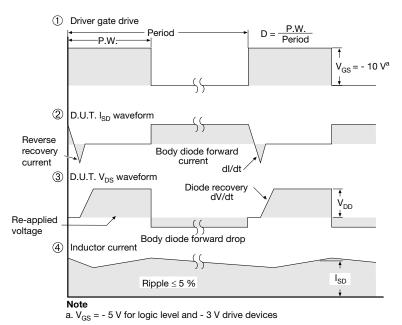


Fig. 14 - For P-Channel

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Vishay Siliconix

TO-220 FULLPAK (High Voltage)

OPTION 1: FACILITY CODE = 9



		MILLIMETERS	
DIM.	MIN.	NOM.	MAX.
Α	4.60	4.70	4.80
b	0.70	0.80	0.91
b1	1.20	1.30	1.47
b2	1.10	1.20	1.30
С	0.45	0.50	0.63
D	15.80	15.87	15.97
е		2.54 BSC	
E	10.00	10.10	10.30
F	2.44	2.54	2.64
G	6.50	6.70	6.90
L	12.90	13.10	13.30
L1	3.13	3.23	3.33
Q	2.65	2.75	2.85
Q1	3.20	3.30	3.40
ØR	3.08	3.18	3.28

- 1. To be used only for process drawing
- 2. These dimensions apply to all TO-220 FULLPAK leadframe versions 3 leads
- 3. All critical dimensions should C meet $C_{pk} > 1.33$
- 4. All dimensions include burrs and plating thickness
- 5. No chipping or package damage
- 6. Facility code will be the 1st character located at the 2nd row of the unit marking



OPTION 2: FACILITY CODE = Y



	MILLIN	MILLIMETERS		INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.570	4.830	0.180	0.190		
A1	2.570	2.830	0.101	0.111		
A2	2.510	2.850	0.099	0.112		
b	0.622	0.890	0.024	0.035		
b2	1.229	1.400	0.048	0.055		
b3	1.229	1.400	0.048	0.055		
С	0.440	0.629	0.017	0.025		
D	8.650	9.800	0.341	0.386		
d1	15.88	16.120	0.622	0.635		
d3	12.300	12.920	0.484	0.509		
Е	10.360	10.630	0.408	0.419		
е	2.54	2.54 BSC		0.100 BSC		
L	13.200	13.730	0.520	0.541		
L1	3.100	3.500	0.122	0.138		
n	6.050	6.150	0.238	0.242		
ØΡ	3.050	3.450	0.120	0.136		
u	2.400	2.500	0.094	0.098		
V	0.400	0.500	0.016	0.020		

ECN: E19-0180-Rev. D, 08-Apr-2019

DWG: 5972

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- 2. These dimensions apply to all TO-220 FULLPAK leadframe versions 3 leads
- 3. All critical dimensions should C meet $C_{pk} > 1.33$
- 4. All dimensions include burrs and plating thickness
- 5. No chipping or package damage
- 6. Facility code will be the 1st character located at the 2nd row of the unit marking



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Vishay

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